

Final datasheet

EasyPACK™ 2B module with CoolSiC™ Trench MOSFET and PressFIT / NTC

Features

- · Electrical features
 - $V_{DSS} = 2000 V$
 - $I_{DN} = 100 \text{ A} / I_{DRM} = 200 \text{ A}$
 - Overload operation up to 175°C
 - Suitable Infineon gate drivers can be found under https://www.infineon.com/gdfinder
- Mechanical features
 - AlN substrate with low thermal resistance
 - High creepage and clearance distances
 - Integrated NTC temperature sensor
 - PressFIT contact technology

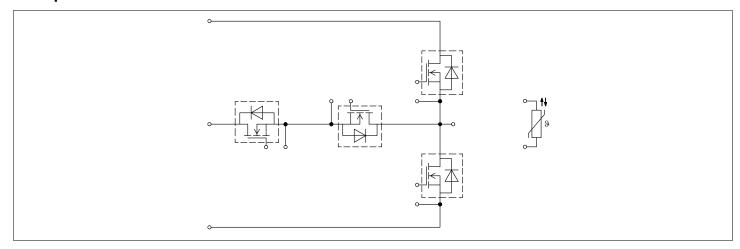
Potential applications

- EV charging
- Three-level applications
- Energy storage systems (ESS)
- Solar applications

Product validation

• Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

Description





EasyPACK™ 2B module





Table of contents

	Description	1
	Features	1
	Potential applications	1
	Product validation	1
	Table of contents	2
1	Package	3
2	MOSFET, T1 / T2	3
3	Body diode (MOSFET, T1 / T2)	5
4	MOSFET, T3 / T4	6
5	Body diode (MOSFET, T3 / T4)	8
6	NTC-Thermistor	9
7	Characteristics diagrams	10
8	Circuit diagram	23
9	Package outlines	24
10	Module label code	25
	Revision history	26
	Disclaimer	27

EasyPACK™ 2B module





Package 1

Insulation coordination Table 1

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V _{ISOL}	RMS, f = 50 Hz, t = 1 min	3.2	kV
Isolation test voltage NTC	V _{ISOL(NTC)}	RMS, f = 50 Hz, t = 1 min	3.2	kV
Internal isolation		basic insulation (class 1, IEC 61140)	AlN	
Comparative tracking index	СТІ		> 200	
Relative thermal index (electrical)	RTI	housing	140	°C

Characteristic values Table 2

Parameter	Symbol	Note or test condition		Values		
			Min.	Тур.	Max.	
Stray inductance module	L _{sCE}			22		nH
Module lead resistance, terminals - chip	R _{CC'+EE'}	T _H = 25 °C, per switch		2.5		mΩ
Storage temperature	$T_{\rm stg}$		-40		125	°C
Mounting force per clamp	F		40		80	N
Weight	G			39		g

The current under continuous operation is limited to 25 A RMS per connector pin. Note:

MOSFET, T1 / T2 2

Table 3 **Maximum rated values**

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}		T _{vj} = 25 °C	2000	V
Implemented drain current	I _{DN}			160	А
Continuous DC drain current	I _{DDC}	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = 18 V	T _H = 65 °C	155	А
Repetitive peak drain current	I _{DRM}	verified by design, t _p lim	nited by T _{vjmax}	320	А
Gate-source voltage, max. transient voltage	V _{GS}			-10/23	V
Gate-source voltage, max. static voltage	V_{GS}			-7/20	V

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Table 4 **Recommended values**

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	V _{GS(on)}		1518	V
Off-state gate voltage	V _{GS(off)}		-52	V

Table 5 **Characteristic values**

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Drain-source on-resistance	R _{DS(on)}	I _D = 100 A	$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		5.1	8.7	mΩ
			V _{GS} = 18 V, T _{vj} = 125 °C		10.7		
			$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 175 ^{\circ}\text{C}$		15.2		
			$V_{\rm GS} = 15 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		5.5		
Gate threshold voltage	V _{GS(th)}	I_D = 112 mA, V_{DS} = V_{GS} , (te pulse at V_{GS} = +20 V), T_{Vj} =		3.45	4.3	5.15	V
Total gate charge	Q_{G}	$V_{\rm DD}$ = 1200 V, $V_{\rm GS}$ = -3 V, T _V	_j = 25 °C		0.78		μC
Internal gate resistor	R _{Gint}	T _{vj} = 25 °C			1.8		Ω
Input capacitance	C _{ISS}	$f = 100 \text{ kHz}, V_{DS} = 1200 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		24.1		nF
Output capacitance	C _{OSS}	$f = 100 \text{ kHz}, V_{DS} = 1200 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		0.563		nF
Reverse transfer capacitance	C _{rss}	$f = 100 \text{ kHz}, V_{DS} = 1200 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		0.041		nF
C _{OSS} stored energy	E _{OSS}	$V_{\rm DS}$ = 1200 V, $V_{\rm GS}$ = -3 V, $T_{\rm V}$	_j = 25 °C		508		μJ
Drain-source leakage current	I _{DSS}	$V_{\rm DS}$ = 2000 V, $V_{\rm GS}$ = -3 V	T _{vj} = 25 °C		0.04	378	μA
Gate-source leakage current	I _{GSS}	$V_{\rm DS}$ = 0 V, $T_{\rm vj}$ = 25 °C	V _{GS} = 20 V			400	nA
Turn-on delay time	t _{d on}	$I_{\rm D} = 100 \text{A}, R_{\rm Gon} = 5.1 \Omega,$	T _{vj} = 25 °C		79		ns
(inductive load)		$V_{\rm DD} = 750 \text{ V}, V_{\rm GS} = -3/18 \text{ V},$ $t_{\rm dead} = 1000 \text{ ns}$	T _{vj} = 125 °C		77		
		dead 1000113	T _{vj} = 175 °C		75		
Rise time (inductive load)	t _r	$I_{\rm D} = 100 \text{A}, R_{\rm Gon} = 5.1 \Omega,$	T _{vj} = 25 °C		77		ns
		$V_{DD} = 750 \text{ V}, V_{GS} = -3/18 \text{ V},$ $t_{dead} = 1000 \text{ ns}$	T _{vj} = 125 °C		74		
		raeaa 1000113	T _{vj} = 175 °C		74		

(table continues...)

EasyPACK™ 2B module

3 Body diode (MOSFET, T1 / T2)



Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
					Тур.	Max.	
Turn-off delay time	t _{d off}	$I_{\rm D} = 100 \text{A}, R_{\rm Goff} = 0.51 \Omega,$	$T_{vi} = 25 °C$		107		ns
(inductive load)		T _{vj} = 125 °C		117			
			T _{vj} = 175 °C		121		
Fall time (inductive load)	t _f	$I_{\rm D} = 100 \text{ A}, R_{\rm Goff} = 0.51 \Omega,$	T _{vj} = 25 °C		18		ns
		$V_{\rm DD} = 750 \text{ V}, V_{\rm GS} = -3/18 \text{ V}$	T _{vj} = 125 °C		19		
			T _{vj} = 175 °C		19		
Turn-on energy loss per pulse	Eon	$I_{\rm D}$ = 100 A, $V_{\rm DD}$ = 750 V,	<i>T</i> _{vj} = 25 °C		3.5		mJ
		$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V}, R_{Gon} = 5.1 \Omega, \text{ di/dt} =$	T _{vj} = 125 °C		3.8		
	4.3 kA/ μ s (T _{vj} = 175 °C), t_{dead} = 1000 ns	T _{vj} = 175 °C		4.1			
Turn-on energy loss per	E _{on,o}	$I_{\rm D} = 100 \text{ A}, V_{\rm DD} = 750 \text{ V},$	T _{vj} = 25 °C		2.4		mJ
pulse, optimized		$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Gon,o} = 3 \Omega, \text{ di/dt} =$	T _{vj} = 125 °C		2.5		
		5.6 kA/ μ s (T _{vj} = 175 °C), t_{dead} = 100 ns	T _{vj} = 175 °C		2.6		
Turn-off energy loss per	E _{off}	$I_{\rm D}$ = 100 A, $V_{\rm DD}$ = 750 V,	T _{vj} = 25 °C		0.71		mJ
pulse		$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Goff} = 0.51 \Omega, \text{ dv/dt} =$	T _{vj} = 125 °C		0.74		1
		31.6 kV/ μ s ($T_{vj} = 175$ °C)	T _{vj} = 175 °C		0.77		
Thermal resistance, junction to heat sink	R _{thJH}	per MOSFET, $\lambda_{\text{grease}} = 5 \text{ W}$	/(m·K)		0.164		K/W
Temperature under switching conditions	T _{vj op}			-40		175	°C

Note:

The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

Tvj op > 150 °C is allowed for operation at overload conditions. For detailed specifications, please refer to AN 2018-14.

3 Body diode (MOSFET, T1 / T2)

Table 6 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward	I _{SD}	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = -3 V	T _H = 65 °C	120	Α
current					

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4 MOSFET, T3 / T4



Table 7 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	-
Forward voltage	V _{SD}	V_{SD} $I_{SD} = 100 \text{ A}, V_{GS} = -3 \text{ V}$	T _{vj} = 25 °C		4	5.55	V
			T _{vj} = 125 °C		3.65		
			T _{vj} = 175 °C		3.6		
Peak reverse recovery	/ _{rrm}	8.1 kA/ μ s, V_{DD} = 750 V, V_{GS} = -3 V, t_{dead} = 1000 ns	T _{vj} = 25 °C		127		А
current			T _{vj} = 125 °C		167		
			T _{vj} = 175 °C		211		
Recovered charge	Qrr	8.1 kA/ μ s, V_{DD} = 750 V, V_{GS} = -3 V, t_{dead} = 1000 ns	T _{vj} = 25 °C		2		μC
			T _{vj} = 125 °C		3.9		
			T _{vj} = 175 °C		5.9		
Reverse recovery energy	E _{rec}	$I_{SD} = 100 \text{ A, di}_{s}/\text{dt} =$	T _{vj} = 25 °C		0.55		mJ
		8.1 kA/ μ s (T_{vj} = 175 °C), V_{DD} = 750 V, V_{GS} = -3 V,	T _{vj} = 125 °C		1.6		
		$t_{\text{dead}} = 1000 \text{ ns}$	T _{vj} = 175 °C		2.6		
Reverse recovery energy, optimized	E _{rec,o}	$I_{SD} = 100 \text{ A, di}_{s}/\text{dt} =$	T _{vi} = 25 °C		0.85		mJ
		11.3 kA/ μ s (T _{vj} = 175 °C), V_{DD} = 750 V, V_{GS} = -3 V,	T _{vj} = 125 °C		1		_
			T _{vj} = 175 °C		1.3		

4 MOSFET, T3 / T4

Table 8 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V _{DSS}		T _{vj} = 25 °C	1200	V
Continuous DC drain current	I _{DDC}	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = 18 V	T _H = 100 °C	100	А
Repetitive peak drain current	/ _{DRM}	verified by design, t _p lim	rerified by design, t _p limited by T _{vjmax}		А
Gate-source voltage, max. transient voltage	V_{GS}			-10/23	V
Gate-source voltage, max. static voltage	V_{GS}			-7/20	V

Table 9 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	V _{GS(on)}		1518	V
Off-state gate voltage	V _{GS(off)}		-50	V

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4 MOSFET, T3 / T4



Table 10 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Drain-source on-resistance	R _{DS(on)}	I _D = 100 A	$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		8.1	12	mΩ
			$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 125 ^{\circ}\text{C}$		13.1		
			$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 175 ^{\circ}\text{C}$		17.4		
			$V_{\rm GS} = 15 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		9.7		
Gate threshold voltage	V _{GS(th)}	$I_D = 40 \text{ mA}, V_{DS} = V_{GS}, T_{vj} = 1 \text{ms pulse at } V_{GS} = +20 \text{ V}.$		3.45	4.3	5.15	V
Total gate charge	Q_{G}	$V_{\rm DD}$ = 800 V, $V_{\rm GS}$ = -3/18 V,	T _{vj} = 25 °C		0.297		μC
Internal gate resistor	R _{Gint}	T _{vj} = 25 °C			2.1		Ω
Input capacitance	C _{ISS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		8.8		nF
Output capacitance	C _{OSS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		0.42		nF
Reverse transfer capacitance	C _{rss}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		0.028		nF
C _{OSS} stored energy	E _{OSS}	$V_{\rm DS}$ = 800 V, $V_{\rm GS}$ = 0 V, $T_{\rm vj}$ =	25 °C		172		μJ
Drain-source leakage current	I _{DSS}	$V_{\rm DS}$ = 100 V, $V_{\rm GS}$ = -3 V	T _{vj} = 25 °C		0.06	380	μA
Gate-source leakage current	I _{GSS}	$V_{\rm DS}$ = 0 V, $T_{\rm vj}$ = 25 °C	$V_{GS} = -3 \text{ V}$			400	nA
Turn-on delay time	t _{d on}	$I_{\rm D} = 100 \text{A}, R_{\rm Gon} = 3.9 \Omega,$	T _{vj} = 25 °C		38		ns
(inductive load)		$V_{DD} = 750 \text{ V}, V_{GS} = -3/18 \text{ V},$ $t_{dead} = 1000 \text{ ns}$	T _{vj} = 125 °C		37		
		dead = 000	T _{vj} = 175 °C		36		
Rise time (inductive load)	t _r	$I_{\rm D} = 100 \text{A}, R_{\rm Gon} = 3.9 \Omega,$	T _{vj} = 25 °C		42		ns
		$V_{DD} = 750 \text{ V}, V_{GS} = -3/18 \text{ V},$ $t_{dead} = 1000 \text{ ns}$	T _{vj} = 125 °C		47		
		tdead 1000113	T _{vj} = 175 °C		51		
Turn-off delay time	t _{d off}	$I_{\rm D} = 100 \text{A}, R_{\rm Goff} = 2.4 \Omega,$	T _{vj} = 25 °C		80		ns
(inductive load)		$V_{\rm DD} = 750 \text{ V}, V_{\rm GS} = -3/18 \text{ V}$	T _{vj} = 125 °C		81		
			T _{vj} = 175 °C		83		
Fall time (inductive load)	t_{f}	$I_{\rm D} = 100 \text{ A}, R_{\rm Goff} = 2.4 \Omega,$	T _{vj} = 25 °C		19		ns
		$V_{\rm DD} = 750 \text{ V}, V_{\rm GS} = -3/18 \text{ V}$	T _{vj} = 125 °C		19		
		T _{vi} = 175 °C			19		

(table continues...)

EasyPACK™ 2B module

5 Body diode (MOSFET, T3 / T4)



Table 10 (continued) Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Turn-on energy loss per pulse	E _{on}	$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V}, R_{Gon} = 3.9 \Omega, \text{ di/dt} = -3/18 \text{ V}$	T _{vj} = 25 °C		2		mJ
			T _{vj} = 125 °C		2.4		-
			T _{vj} = 175 °C		2.8		
Turn-on energy loss per pulse, optimized $E_{on,o}$	E _{on,o}	$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V}, R_{GOD, O} = 0.51 \Omega, \text{ di/dt} = $	T _{vj} = 25 °C		0.99		mJ
			T _{vj} = 125 °C		0.99		
			T _{vj} = 175 °C		1.03		
Turn-off energy loss per	E _{off}	$I_{\rm D}$ = 100 A, $V_{\rm DD}$ = 750 V,	T _{vj} = 25 °C		0.52		mJ
pulse		$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Goff} = 2.4 \Omega, \text{ dv/dt} = 31.6$	T _{vj} = 125 °C		0.57		
		$kV/\mu s (T_{vj} = 175 °C)$	T _{vj} = 175 °C		0.6		
Thermal resistance, junction to heat sink	R _{thJH}	per MOSFET, $\lambda_{\text{grease}} = 5 \text{ W}$	/(m·K)		0.288		K/W
Temperature under switching conditions	T _{vj op}			-40		175	°C

Note:

The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

 $Tvj op > 150 \,^{\circ}\text{C}$ is allowed for operation at overload conditions. For detailed specifications, please refer to AN 2018-14.

5 Body diode (MOSFET, T3 / T4)

Table 11 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward	I _{SD}	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = -3 V	T _H = 65 °C	80	Α
current					

Table 12 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Мах.	
Forward voltage	V_{SD}	$I_{SD} = 100 \text{ A}, V_{GS} = -3 \text{ V}$	T _{vj} = 25 °C		4.2	5.35	V
			T _{vj} = 125 °C		3.9		1
			T _{vj} = 175 °C		3.8		1

(table continues...)

EasyPACK™ 2B module

6 NTC-Thermistor



Table 12 (continued) Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Peak reverse recovery current	I _{rrm}	$I_{SD} = 100 \text{ A}, \text{ di}_{\text{s}}/\text{dt} = 4.3 \text{ kA}/\mu\text{s}, V_{DD} = 750 \text{ V}, V_{GS} = -3 \text{ V}, t_{\text{dead}} = 1000 \text{ ns}$	T _{vj} = 25 °C		53		A
			T _{vj} = 125 °C		74		
		VGS - 3 V, tdead - 1000 113	T _{vj} = 175 °C		89		
Recovered charge		4.2 1.4/1.0 1/ - 7501/	T _{vj} = 25 °C		1		μС
			T _{vj} = 125 °C		1.8		
			T _{vj} = 175 °C		2.4		
Reverse recovery energy	E _{rec}	I_{SD} = 100 A, di _s /dt = 4.3 kA/µs (T _{vj} = 175 °C), V_{DD} = 750 V, V_{GS} = -3 V, t_{dead} = 1000 ns	T _{vj} = 25 °C		0.26		mJ
			T _{vj} = 125 °C		0.48		
			T _{vj} = 175 °C		0.64		
Reverse recovery energy, optimized	E _{rec,o}	$I_{SD} = 100 \text{ A, di}_{s}/\text{dt} = 5.6 \text{ kA/}\mu\text{s} (T_{vj} = 175 ^{\circ}\text{C}),$	T _{vj} = 25 °C		0.27		mJ
			T _{vj} = 125 °C		0.35		
		$V_{\rm DD} = 750 \text{ V}, V_{\rm GS} = -3 \text{ V},$ $t_{\rm dead} = 100 \text{ ns}$	T _{vj} = 175 °C		0.43		

6 NTC-Thermistor

Table 13 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Тур.	Max.	1
Rated resistance	R ₂₅	T _{NTC} = 25 °C		5		kΩ
Deviation of R ₁₀₀	∆R/R	$T_{\rm NTC}$ = 100 °C, R_{100} = 493 Ω	-5		5	%
Power dissipation	P ₂₅	T _{NTC} = 25 °C			20	mW
B-value	B _{25/50}	$R_2 = R_{25} \exp[B_{25/50}(1/T_2-1/(298,15 \text{ K}))]$		3375		K
B-value	B _{25/80}	$R_2 = R_{25} \exp[B_{25/80}(1/T_2-1/(298,15 \text{ K}))]$		3411		K
B-value	B _{25/100}	$R_2 = R_{25} \exp[B_{25/100}(1/T_2-1/(298,15 \text{ K}))]$ 3433			K	

Note: For an analytical description of the NTC characteristics please refer to AN2009-10, chapter 4

7 Characteristics diagrams

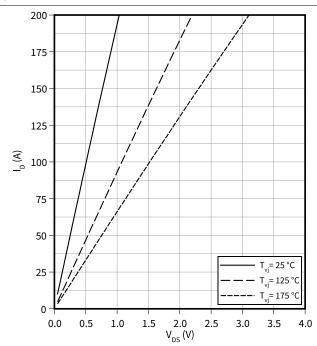


7 Characteristics diagrams

Output characteristic (typical), MOSFET, T1 / T2

 $I_D = f(V_{DS})$

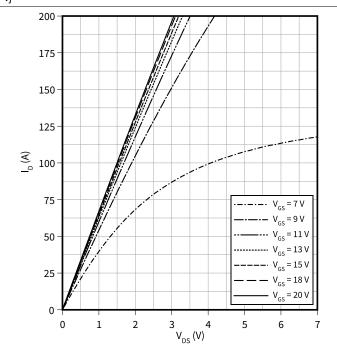
 $V_{GS} = 18 V$



Output characteristic field (typical), MOSFET, T1 / T2

 $I_D = f(V_{DS})$

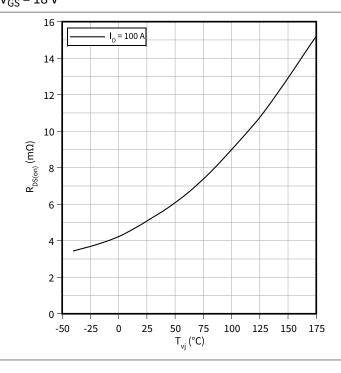
T_{vj} = 25 °C



Drain source on-resistance (typical), MOSFET, T1 / T2

 $R_{DS(on)} = f(T_{vj})$

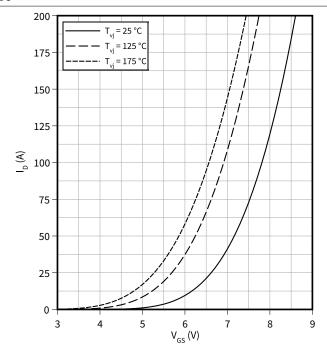
V_{GS} = 18 V



Transfer characteristic (typical), MOSFET, T1 / T2

 $I_D = f(V_{GS})$

 $V_{DS} = 20 \text{ V}$



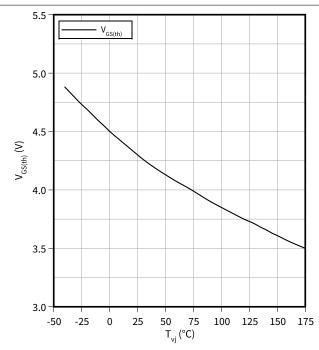
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7 Characteristics diagrams

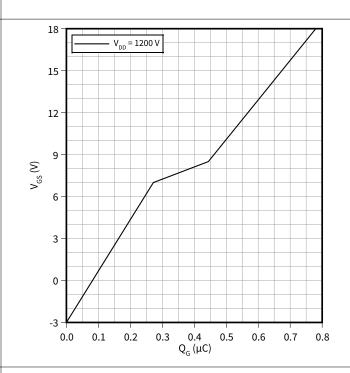
Gate-source threshold voltage (typical), MOSFET, T1 / T2

 $V_{GS(th)} = f(T_{vj})$ $I_D = 112 \text{ mA}, V_{GS} = V_{DS}$



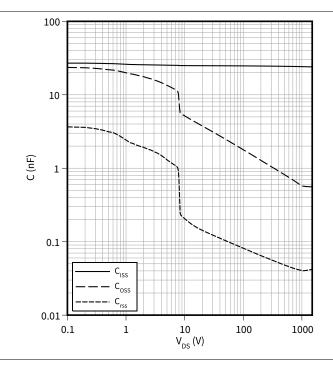
Gate charge characteristic (typical), MOSFET, T1 / T2

 $V_{GS} = f(Q_G)$ $I_D = 100 \text{ A}, T_{vj} = 25 \text{ °C}$



Capacity characteristic (typical), MOSFET, T1 / T2

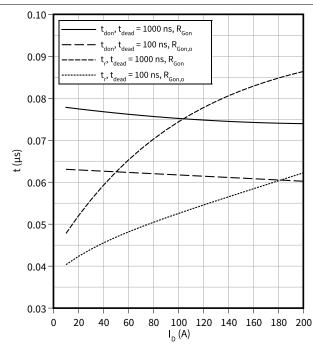
 $C = f(V_{DS})$ f = 100 kHz, T_{vi} = 25 °C, V_{GS} = 0 V



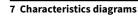
Switching times (typical), MOSFET, T1 / T2

 $t = t(I_D)$

 R_{Gon} = 5.1 Ω , V_{DD} = 750 V, $R_{Gon,o}$ = 3 Ω , T_{vj} = 175 °C, V_{GS} = -3/18 V



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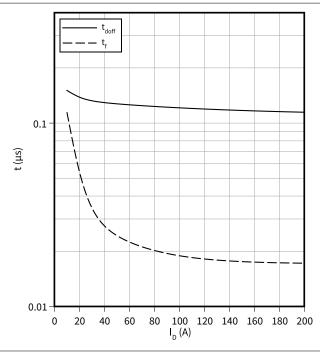




Switching times (typical), MOSFET, T1 $\!\!/$ T2

 $t = f(I_D)$

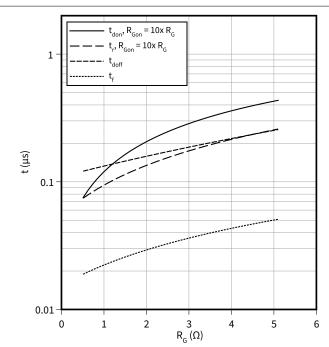
$$R_{Goff} = 0.51 \Omega$$
, $V_{DD} = 750 V$, $T_{vj} = 175 °C$, $V_{GS} = -3/18 V$



Switching times (typical), MOSFET, T1 / T2

 $t = f(R_G)$

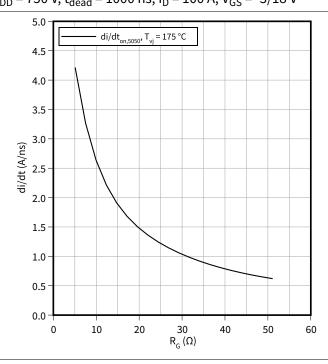
 V_{DD} = 750 V, t_{dead} = 1000 ns, I_{D} = 100 A, T_{vj} = 175 °C, V_{GS} = -3/18 V



Current slope (typical), MOSFET, T1 / T2

 $di/dt = f(R_G)$

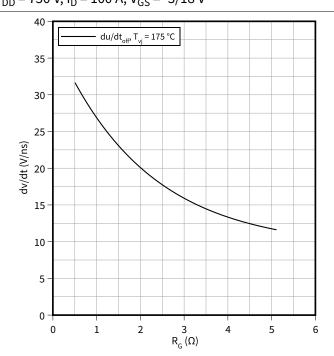
$$V_{DD}$$
 = 750 V, t_{dead} = 1000 ns, I_{D} = 100 A, V_{GS} = -3/18 V



Voltage slope (typical), MOSFET, T1 / T2

 $dv/dt = f(R_G)$

 $V_{DD} = 750 \text{ V}, I_D = 100 \text{ A}, V_{GS} = -3/18 \text{ V}$



EasyPACK™ 2B module

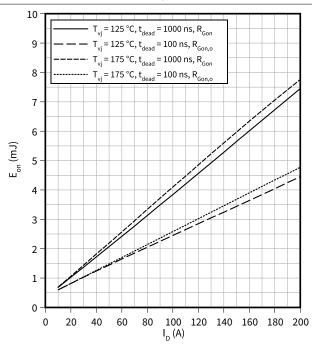




Switching losses (typical), MOSFET, T1 / T2

 $E_{on} = f(I_D)$

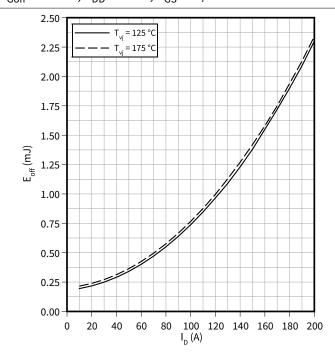
$$V_{DD}$$
 = 750 V, R_{Gon} = 5.1 Ω , $R_{Gon,o}$ = 3 Ω , V_{GS} = -3/18 V



Switching losses (typical), MOSFET, T1 / T2

 $E_{off} = f(I_D)$

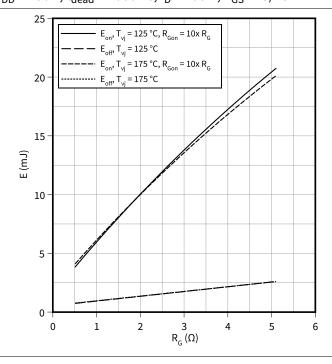
$$R_{Goff}$$
 = 0.51 Ω , V_{DD} = 750 V , V_{GS} = -3/18 V



Switching losses (typical), MOSFET, T1 / T2

 $E = f(R_G)$

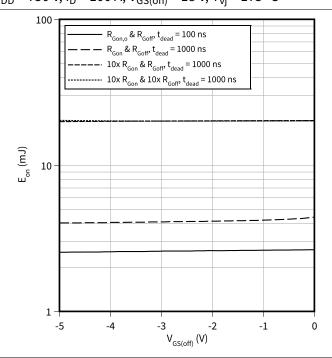
$$V_{DD} = 750 \text{ V}, t_{dead} = 1000 \text{ ns}, I_{D} = 100 \text{ A}, V_{GS} = -3/18 \text{ V}$$



Switching losses (typical), MOSFET, T1 / T2

 $E_{on} = f(V_{GS(off)})$

$$V_{DD} = 750 \text{ V}, I_D = 100 \text{ A}, V_{GS(on)} = 18 \text{ V}, T_{vj} = 175 ^{\circ}\text{C}$$



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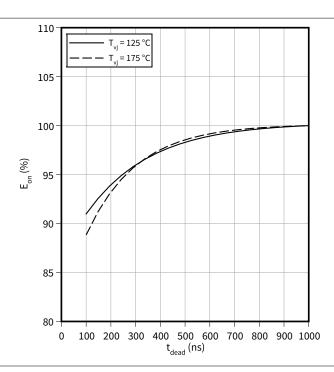


7 Characteristics diagrams

Switching losses (typical), MOSFET, T1 $\!\!\!/$ T2

$$E_{on} = f(t_{dead})$$

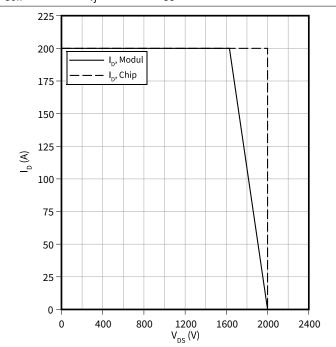
$$R_{Gon} = 5.1 \Omega$$
, $V_{DS} = 750 V$, $I_{D} = 100 A$, $V_{GS} = -3/18 V$



Reverse bias safe operating area (RBSOA), MOSFET, T1/T2

$$I_D = f(V_{DS})$$

$$R_{Goff} = 0.51 \Omega$$
, $T_{vi} = 175 °C$, $V_{GS} = -3/18 V$



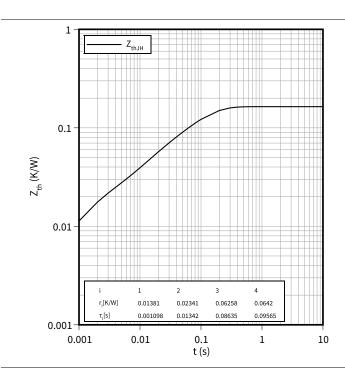
Transient thermal impedance, MOSFET, T1 / T2

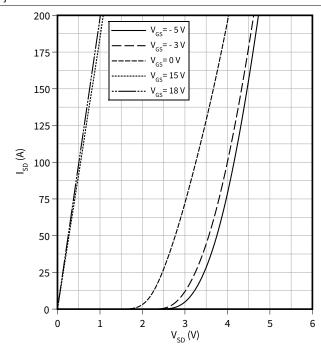
$$Z_{th} = f(t)$$

Forward characteristic body diode (typical), MOSFET, T1 / T2 $\,$

$$I_{SD} = f(V_{SD})$$

$$T_{vi} = 25 \,^{\circ}C$$





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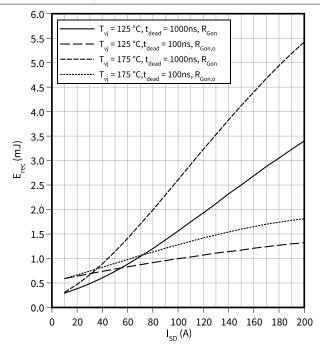


7 Characteristics diagrams

Switching losses body diode (typical), MOSFET, T1 $\!\!/$ T2

 $E_{rec} = f(I_{SD})$

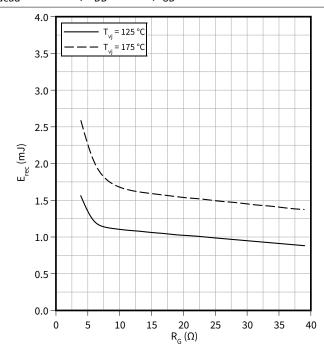
$$R_{Gon} = 3.9 \Omega$$
, $R_{Gon,o} = 0.51 \Omega$, $V_{DD} = 750 V$



Switching losses body diode (typical), MOSFET, T1 / T2

 $E_{rec} = f(R_G)$

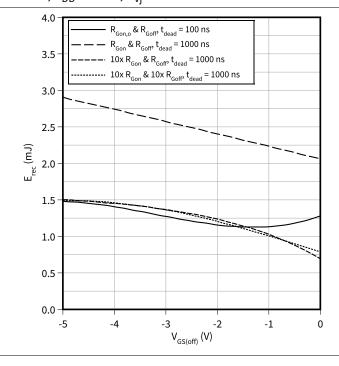
 $t_{dead} = 1000 \text{ ns}, V_{DD} = 750 \text{ V}, I_{SD} = 100 \text{ A}$



Switching losses body diode (typical), MOSFET, T1 / T2

 $E_{rec} = f(V_{GS(off)})$

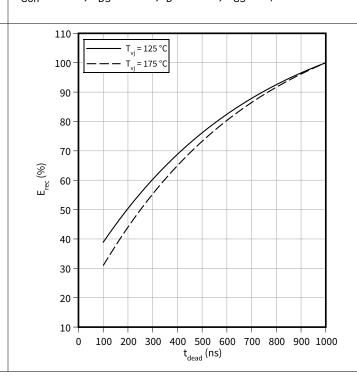
 R_{Goff} = 2.4 Ω , R_{Gon} = 3.9 Ω , $V_{GS(on)}$ = 18 V, I_{SD} = 100 A, $R_{Gon,o}$ = 0.51 Ω , V_{DD} = 750 V, T_{vj} = 175 °C



Switching losses body diode (typical), MOSFET, T1 / T2

 $E_{rec} = f(t_{dead})$

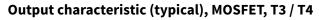
 $R_{Gon} = 3.9 \Omega$, $V_{DS} = 750 V$, $I_{D} = 100 A$, $V_{GS} = -3/18 V$



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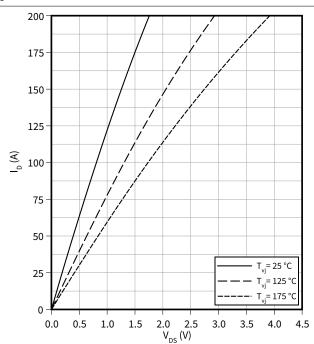


7 Characteristics diagrams



 $I_D = f(V_{DS})$

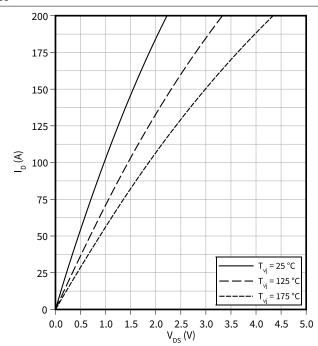
 $V_{GS} = 18 V$



Output characteristic (typical), MOSFET, T3 / T4

 $I_D = f(V_{DS})$

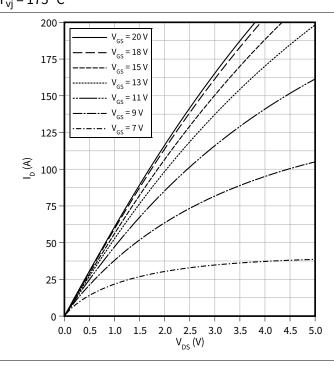
 $V_{GS} = 15 V$



Output characteristic field (typical), MOSFET, T3 / T4

 $I_D = f(V_{DS})$

 $T_{vi} = 175 \,^{\circ}\text{C}$

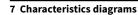


Drain source on-resistance (typical), MOSFET, T3 / T4

 $R_{DS(on)} = f(I_D)$

 $V_{GS} = 18 \text{ V}$

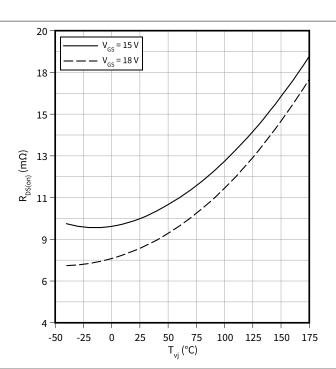
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Drain source on-resistance (typical), MOSFET, T3 / T4

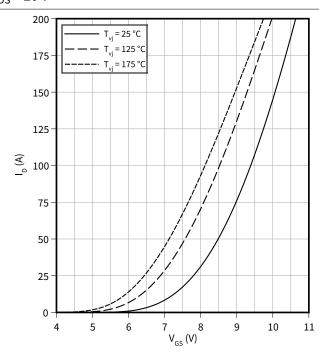
 $R_{DS(on)} = f(T_{vj})$



Transfer characteristic (typical), MOSFET, T3 / T4

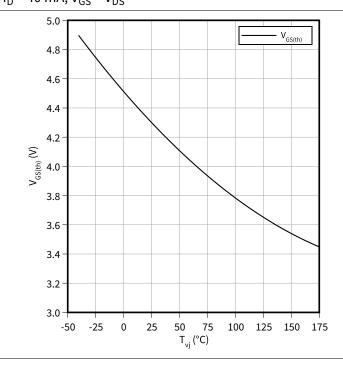
 $I_D = f(V_{GS})$

 $V_{DS} = 20 V$



Gate-source threshold voltage (typical), MOSFET, T3 / T4

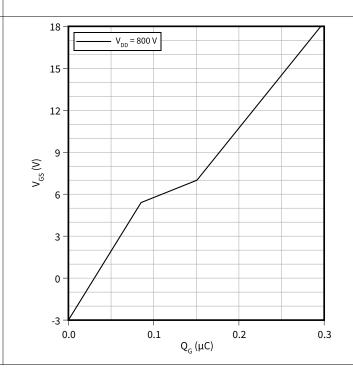
 $V_{GS(th)} = f(T_{vj})$ $I_D = 40 \text{ mA}, V_{GS} = V_{DS}$



Gate charge characteristic (typical), MOSFET, T3 / T4

 $V_{GS} = f(Q_G)$

 $I_D = 100 \text{ A}, T_{vj} = 25 ^{\circ}\text{C}$



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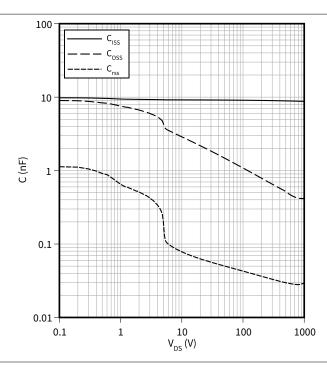


7 Characteristics diagrams

Capacity characteristic (typical), MOSFET, T3 / T4

 $C = f(V_{DS})$

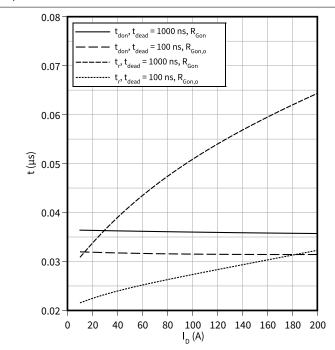
f = 100 kHz, $T_{vj} = 25 \,^{\circ}\text{C}$, $V_{GS} = 0 \,^{\circ}\text{V}$



Switching times (typical), MOSFET, T3 / T4

 $t = f(I_D)$

 V_{DD} = 750 V, R_{Gon} = 3.9 Ω , $R_{Gon,o}$ = 0.51 Ω , T_{vj} = 175 °C, V_{GS} = -3/18 V



Switching times (typical), MOSFET, T3 / T4

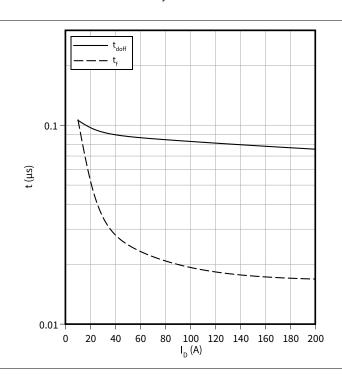
 $t = f(I_D)$

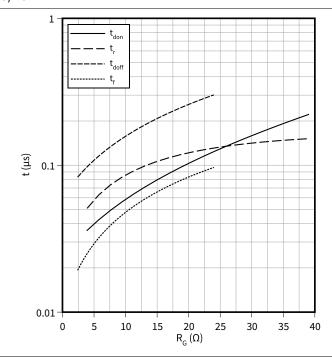
 $R_{Goff} = 2.4 \Omega$, $V_{DD} = 750 V$, $T_{vj} = 175 °C$, $V_{GS} = -3/18 V$

Switching times (typical), MOSFET, T3 / T4

 $t = f(R_G)$

 V_{DD} = 750 V, t_{dead} = 1000 ns, I_D = 100 A, T_{vj} = 175 °C, V_{GS} = -3/18 V





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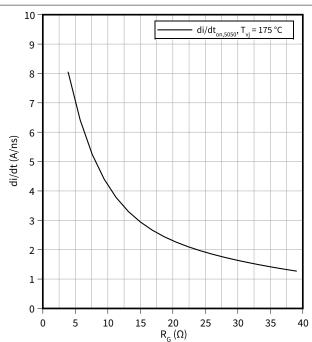


7 Characteristics diagrams

Current slope (typical), MOSFET, T3 / T4

 $di/dt = f(R_G)$

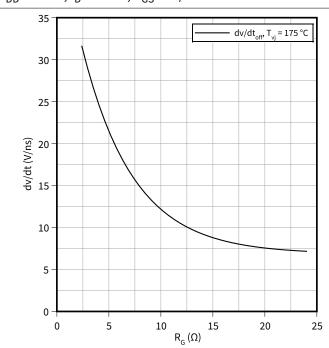
 V_{DD} = 750 V, t_{dead} = 1000 ns, I_{D} = 100 A, V_{GS} = -3/18 V



Voltage slope (typical), MOSFET, T3 / T4

 $dv/dt = f(R_G)$

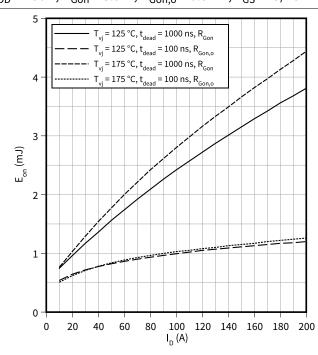
 $V_{DD} = 750 \text{ V}, I_D = 100 \text{ A}, V_{GS} = -3/18 \text{ V}$



Switching losses (typical), MOSFET, T3 / T4

 $E_{on} = f(I_D)$

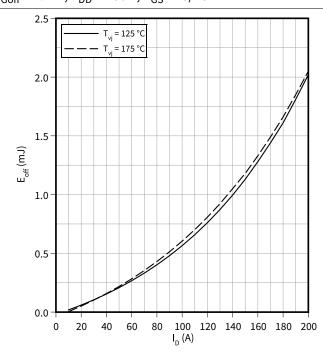
 $V_{DD} = 750 \text{ V}, R_{Gon} = 3.9 \Omega, R_{Gon,o} = 0.51 \Omega, V_{GS} = -3/18 \text{ V}$



Switching losses (typical), MOSFET, T3 / T4

 $E_{off} = f(I_D)$

 $R_{Goff} = 2.4 \Omega$, $V_{DD} = 750 V$, $V_{GS} = -3/18 V$



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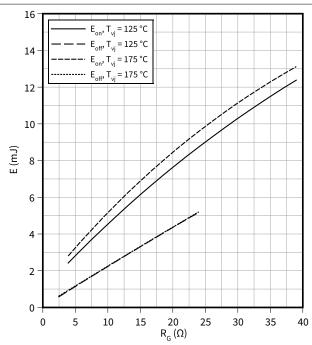




Switching losses (typical), MOSFET, T3 / T4

 $E = f(R_G)$

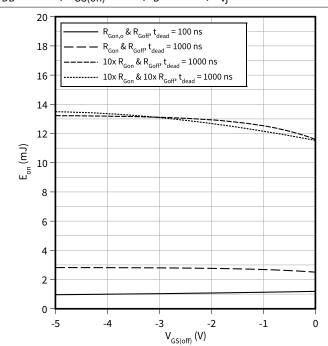
 V_{DD} = 750 V, t_{dead} = 1000 ns, I_{D} = 100 A, V_{GS} = -3/18 V



Switching losses (typical), MOSFET, T3 / T4

 $E_{on} = f(V_{GS(off)})$

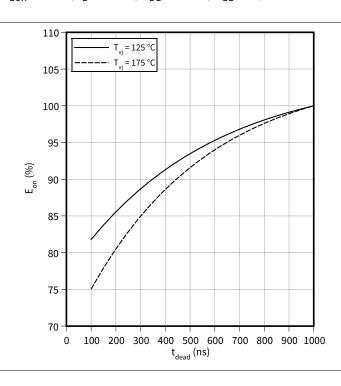
 $V_{DD} = 750 \text{ V}, V_{GS(on)} = 18 \text{ V}, I_{D} = 100 \text{ A}, T_{vi} = 175 ^{\circ}\text{C}$



Switching losses (typical), MOSFET, T3 / T4

 $E_{on} = f(t_{dead})$

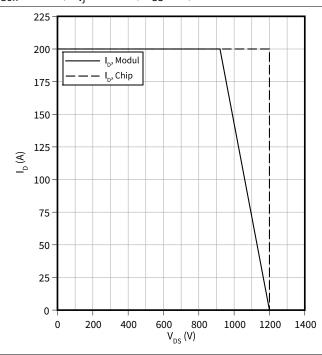
 $R_{Gon} = 3.9 \Omega$, $I_D = 100 A$, $V_{DD} = 750 V$, $V_{GS} = -3/18 V$



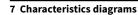
Reverse bias safe operating area (RBSOA), MOSFET, T3 / T4

 $I_D = f(V_{DS})$

 $R_{Goff} = 2.4 \Omega, T_{vi} = 175 \, ^{\circ}C, V_{GS} = -3/18 \, V$



EasyPACK™ 2B module



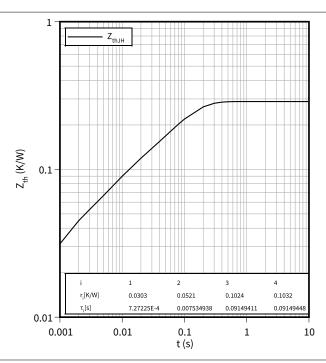


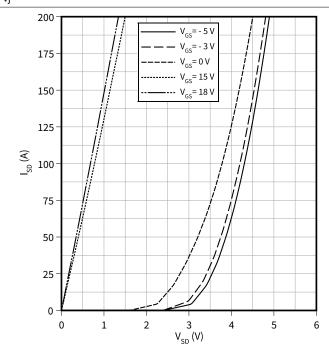
Transient thermal impedance, MOSFET, T3 / T4 $\,$

 $Z_{th} = f(t)$

Forward characteristic body diode (typical), MOSFET, T3 / T4

 $I_{SD} = f(V_{SD})$

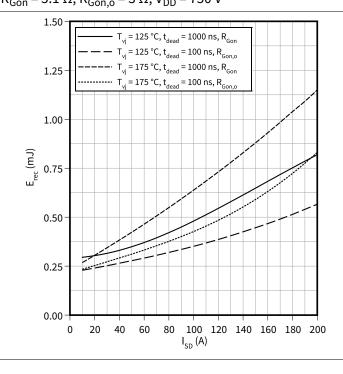




Switching losses body diode (typical), MOSFET, T3 / T4

 $E_{rec} = f(I_{SD})$

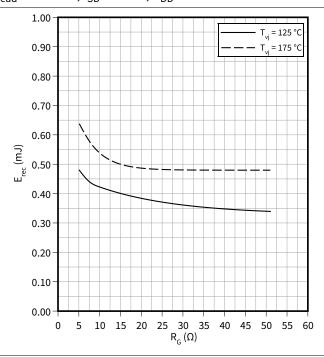
$$R_{Gon} = 5.1 \Omega$$
, $R_{Gon,o} = 3 \Omega$, $V_{DD} = 750 V$



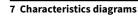
Switching losses body diode (typical), MOSFET, T3 / T4

 $E_{rec} = f(R_G)$

 t_{dead} = 1000 ns, I_{SD} = 100 A, V_{DD} = 750 V



EasyPACK™ 2B module

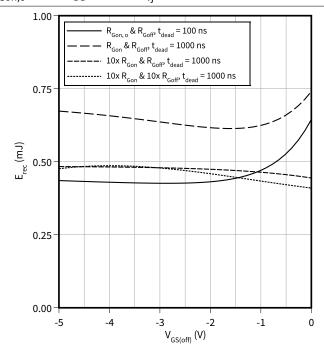




Switching losses body diode (typical), MOSFET, T3 / T4

$$E_{rec} = f(V_{GS(off)})$$

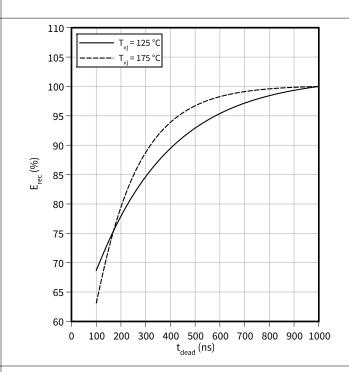
$$R_{Goff}$$
 = 0.51 Ω , R_{Gon} = 5.1 Ω , $V_{GS(on)}$ = 18 V, I_{SD} = 100 A, $R_{Gon,o}$ = 3 Ω , V_{DD} = 750 V, T_{vj} = 175 °C



Switching losses body diode (typical), MOSFET, T3 / T4

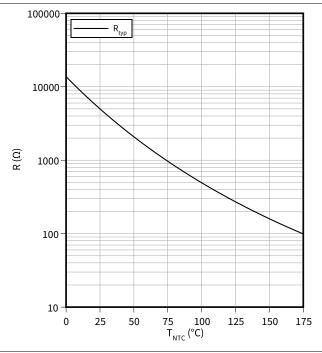
$$E_{rec} = f(t_{dead})$$

 $R_{Gon} = 5.1 \Omega$, $I_D = 100 A$, $V_{DD} = 750 V$, $V_{GS} = -3/18 V$



Temperature characteristic (typical), NTC-Thermistor

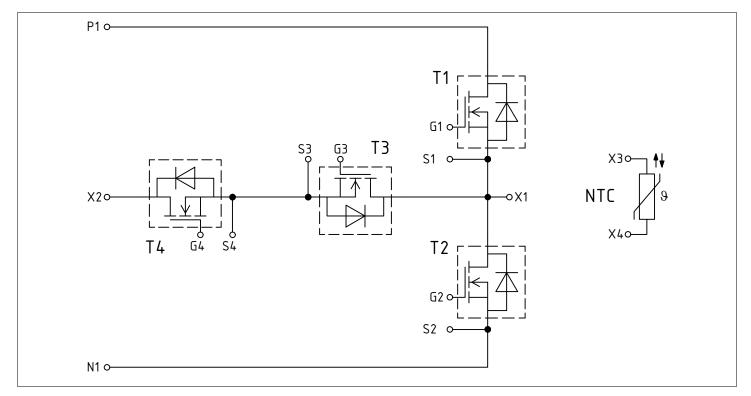
 $R = f(T_{NTC})$



8 Circuit diagram



8 Circuit diagram



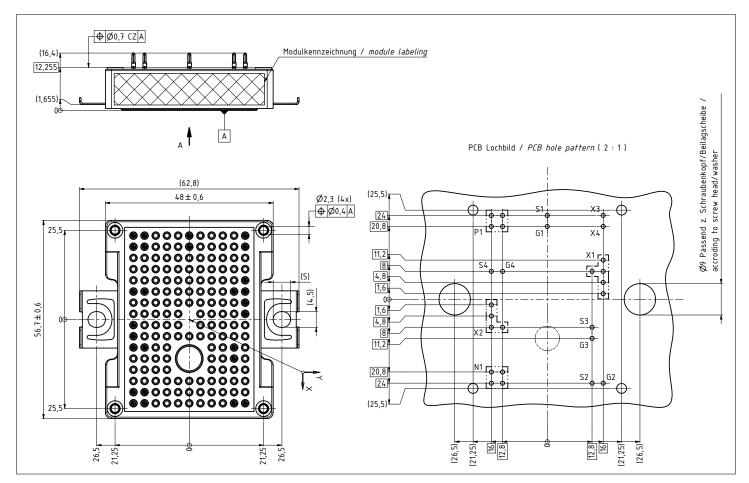
23

Figure 1

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9 Package outlines

9 Package outlines



24

Figure 2

EasyPACK™ 2B module

10 Module label code

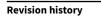


10 Module label code

Module label cod			1		
Code format	Data Matrix		Barcode Code128		
Encoding	ASCII text		Code Set A	A	
Symbol size	16x16		23 digits		
Standard	IEC24720 and IEC16022	IEC24720 and IEC16022			
Code content	Content	Digit		Example	
	Module serial number	1		71549	
	Module material number	6 - 11		142846	
	Production order number	12 - 19		55054991	
	Date code (production year)	20 – 21	15		
	Date code (production week) 22 – 23			30	
Example					

Figure 3

EasyPACK™ 2B module





Revision history

Document revision	Date of release	Description of changes
0.10	2024-03-18	Initial version
1.00	2024-08-23	Final datasheet
1.10	2024-10-17	Final datasheet
1.20	2025-03-05	Final datasheet

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 ${\bf Email: erratum@infineon.com}$

Document reference IFX-ABK103-004

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